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• Four Modes of Operation:

Hold (Store) Shift Right Shift Left Load Data

- Operates With Outputs Enabled or at High Impedance
- 3-State Outputs Drive Bus Lines Directly
- Can Be Cascaded for N-Bit Word Lengths
- Direct Overriding Clear
- Applications:

Stacked or Push-Down Registers Buffer Storage Accumulator Registers

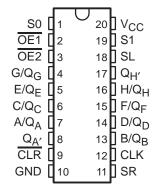
 Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

#### description

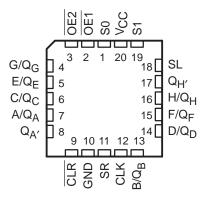
These 8-bit universal shift/storage registers feature multiplexed I/O ports to achieve full 8-bit data handling in a single 20-pin package. Two function-select (S0, S1) inputs and two output-enable (OE1, OE2) inputs can be used to choose the modes of operation listed in the function table.

Synchronous parallel loading is accomplished by taking both S0 and S1 high. This places the 3-state outputs in a high-impedance state and permits

SN54F299 . . . J PACKAGE SN74F299 . . . DW OR N PACKAGE (TOP VIEW)



SN54F299 . . . FK PACKAGE (TOP VIEW)



data that is applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs when the clear (CLR) input is low. Taking either OE1 or OE2 high disables the outputs but has no effect on clearing, shifting, or storage of data.

The SN54F299 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74F299 is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C.

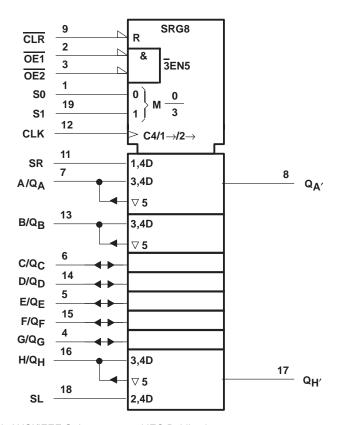
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#### **FUNCTION TABLE**

MODE		INPUTS I/O PORTS							OUTPUTS									
MODE	CLR	S1	S0	OE1†	OE2†	CLK	SL	SR	A/Q <sub>A</sub>	B/QB	C/QC	D/QD	E/Q <sub>E</sub>	F/Q <sub>F</sub>	G/Q <sub>G</sub>	H/Q <sub>H</sub>	$Q_{A'}$	$Q_{H'}$
Clear	L L L	X L H	L X H	L L X	L L X	X X X	X X X	X X X	L L X	L L L	L L L							
Hold	H H	L X	L X	L L	L L	X L	X X	X X	Q <sub>A0</sub> Q <sub>A0</sub>	Q <sub>B0</sub> Q <sub>B0</sub>	Q <sub>C0</sub>	Q <sub>D0</sub> Q <sub>D0</sub>	Q <sub>E0</sub> Q <sub>E0</sub>	Q <sub>F0</sub> Q <sub>F0</sub>	Q <sub>G0</sub> Q <sub>G0</sub>	Q <sub>H0</sub> Q <sub>H0</sub>	Q <sub>A0</sub> Q <sub>A0</sub>	Q <sub>H0</sub> Q <sub>H0</sub>
Shift Right	H H	L L	H H	L L	L L	↑ ↑	X X	H L	H L	Q <sub>An</sub> Q <sub>An</sub>	Q <sub>Bn</sub> Q <sub>Bn</sub>	Q <sub>Cn</sub> Q <sub>Cn</sub>	Q <sub>Dn</sub> Q <sub>Dn</sub>	Q <sub>En</sub> Q <sub>En</sub>	Q <sub>Fn</sub> Q <sub>Fn</sub>	Q <sub>Gn</sub> Q <sub>Gn</sub>	H L	Q <sub>Gn</sub> Q <sub>Gn</sub>
Shift Left	H H	H H	L L	L L	L L	<b>↑</b>	H L	X X	Q <sub>Bn</sub> Q <sub>Bn</sub>	Q <sub>Cn</sub> Q <sub>Cn</sub>	Q <sub>Dn</sub> Q <sub>Dn</sub>	Q <sub>En</sub> Q <sub>En</sub>	Q <sub>Fn</sub> Q <sub>Fn</sub>	Q <sub>Gn</sub> Q <sub>Gn</sub>	Q <sub>Hn</sub> Q <sub>Hn</sub>	H L	Q <sub>Bn</sub> Q <sub>Bn</sub>	H L
Load	Н	Н	Н	Х	Χ	1	Χ	Х	а	b	С	d	е	f	g	h	а	h

NOTE: a . . . h = the level of the steady-state input at inputs A through H, respectively. This data is loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.

# logic symbol<sup>‡</sup>



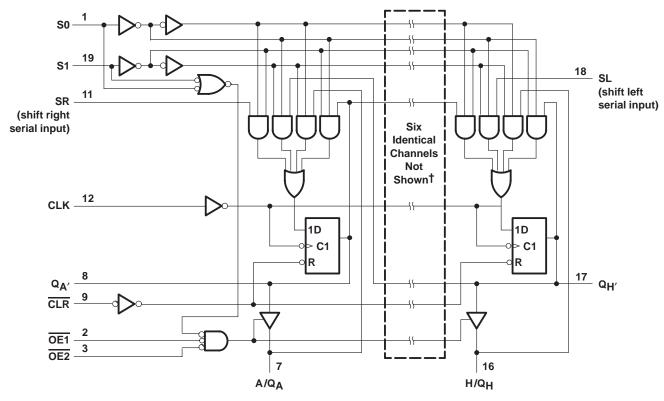
<sup>&</sup>lt;sup>‡</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



<sup>†</sup> When one or both output-enable inputs are high the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

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### logic diagram (positive logic)



 $\dagger$  I/O ports not shown: B/QB (13), C/QC (6), D/QD (14), E/QE (5), F/QF (15), and G/QG (4).

# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub>		1.2 V to 7 V
Input current range  Voltage range applied to any output in the		
Voltage range applied to any output in the		
Current into any output in the low state:		
	SN54F299 (Q <sub>A</sub> thru Q <sub>H</sub> )	
	SN74F299 (Q <sub>A</sub> thru Q <sub>H</sub> )	
Operating free-air temperature range:	SN54F299	–55°C to 125°C
	SN74F299	0°C to 70°C
Storage temperature range		−65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.



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#### recommended operating conditions

				SN54F299			SN74F299			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage		2			2			V	
V <sub>IL</sub>	Low-level input voltage				0.8			0.8	V	
ΙΙΚ	Input clamp current				-18			-18	mA	
lau	High-level output current	Q <sub>A</sub> ' or Q <sub>H</sub> '			<b>–</b> 1			- 1	mA	
ЮН	r light-level output current	Q <sub>A</sub> thru Q <sub>H</sub>			-3			-1	IIIA	
la.	Low level output ourrent	Q <sub>A</sub> ' or Q <sub>H</sub> '			20			20	mA	
IOL	Low-level output current QA thru QH				20			24	IIIA	
T <sub>A</sub>	Operating free-air temperature	•	-55		125	0		70	°C	

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DAMETER	TEC	CONDITIONS	s	N54F299	9	S	N74F299	)	LINUT
P P	RAMETER	IEST	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
VIK		$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	Q <sub>A</sub> ′ or Q <sub>H</sub> ′		$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.5	3.4		
\/0	Q <sub>A</sub> thru Q <sub>H</sub>	V <sub>CC</sub> = 4.5 V	$I_{OH} = -1 \text{ mA}$	2.5	3.4		2.5	3.4		V
VOH	QA IIIIU QH		$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		v
	Any output	$V_{CC} = 4.75 \text{ V},$	$I_{OH} = -1 \text{ mA to } -3 \text{ mA}$				2.7			
	Q <sub>A</sub> ' or Q <sub>H</sub> '		$I_{OL} = 20 \text{ mA}$		0.3	0.5		0.3	0.5	
VOL	Q <sub>A</sub> thru Q <sub>H</sub>	V <sub>CC</sub> = 4.5 V	$I_{OL} = 20 \text{ mA}$		0.3	0.5				V
OL	QA IIIIU QH		$I_{OL} = 24 \text{ mA}$					0.35	0.5	
Ī	A thru H	V00 - 5 5 V	V <sub>I</sub> = 5.5 V			1			1	mA
ΙŢ	Any other	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1			0.1	IIIA
t†	A thru H	V00 - 5 5 V	V <sub>I</sub> = 2.7 V			70			70	
ΊН <sup>‡</sup>	Any other	V <sub>CC</sub> = 5.5 V,	V   = 2.7 V			20			20	μΑ
	A thru H					-0.65			-0.65	
I <sub>IL</sub> ‡	S0 or S1	$V_{CC} = 5.5 \text{ V},$	$V_{I} = 0.5 V$	-1.2			-1.2		mA	
	Any other	]			-0.6			-0.6		
IOS§		$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 0	-60		-150	-60		-150	mA
Icc		V <sub>CC</sub> = 5.5 V,	See Note 2		68	95		68	95	mA

<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. ‡ For I/O ports ( $Q_A$  thru  $Q_H$ ), the parameters  $I_{IH}$  and  $I_{IL}$  include the off-state output current.

<sup>§</sup> Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second. NOTE 2: ICC is measured with OE1, OE2, and CLK at 4.5 V.

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# timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

				V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C		SN54F299		SN74F299		UNIT	
	,				99 MAX	MIN	MAX	MIN	MAX		
f <sub>clock</sub>	Clock frequency			0	70	0	65	0	70	MHz	
	Pulse duration	CLK high or low		7		8		7		ns	
t <sub>W</sub>	Pulse duration	CLR low		7		8		7		115	
	Setup time before	S0 or S1	High or low	8.5		9.5		8.5			
t	CLK↑	A/Q <sub>A</sub> thru H/Q <sub>H</sub> , SR, or SL	High or low	5.5		6.5		5.5		ns	
t <sub>su</sub>	Inactive-state setup time before CLK↑†	CLR	High	7		13		7		ris	
4.	Hold time after OLKA	S0 or S1	High or low	0		0		0		no	
t <sub>h</sub>	Hold time after CLK↑	A/Q <sub>A</sub> thru H/Q <sub>H</sub> , SR, or SL	High or low	2	·	2		2		ns	

<sup>†</sup> Inactive-state setup time is also referred to as recovery time.

#### switching characteristics (see Note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 5 V, $C_{L}$ = 50 pF, $R_{L}$ = 500 Ω, $T_{A}$ = 25°C			V <sub>C</sub> C <sub>L</sub> R <sub>L</sub> T <sub>A</sub>	UNIT				
				′F299			F299	SN74F299			
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
f <sub>max</sub>			70	100		65		70		MHz	
t <sub>PLH</sub>	CLK	Q <sub>A</sub> ′ or Q <sub>H</sub> ′	3.2	6.6	9	2.7	10.5	3.2	10	ns	
<sup>t</sup> PHL			2.7	6.1	8.5	2.2	10	2.7	9.5		
<sup>t</sup> PLH	CLK	Q <sub>A</sub> thru Q <sub>H</sub>	3.2	6.6	9	2.7	11	3.2	10	ns	
<sup>t</sup> PHL			4.2	8.1	11	3.7	12.5	4.2	12		
<b>4</b>	- OLD	Q <sub>A′</sub> or Q <sub>H′</sub>	3.7	7.1	9.5	3.2	11.5	3.7	10.5	ns	
<sup>t</sup> PHL	CLR	Q <sub>A</sub> thru Q <sub>H</sub>	5.7	10.6	14	5	15.5	5.7	15		
<sup>t</sup> PZH	OE1 or OE2	O three O	2.7	5.6	8	2.2	10.5	2.7	9	ns	
tPZL		Q <sub>A</sub> thru Q <sub>H</sub>	3.2	6.6	10	2.7	12	3.2	11		
<sup>t</sup> PHZ	OE1 or OE2	Q <sub>A</sub> thru Q <sub>H</sub>	1.7	4.1	6	1.7	9	1.7	7	ns	
<sup>t</sup> PLZ	OLI 01 OLZ		1.2	3.6	5.5	1.2	7.5	1.2	6.5		

<sup>&</sup>lt;sup>‡</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 3: Load circuits and waveforms are shown in Section 1.



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